Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/591,051	ST. JOHN ET AL.
Examiner	Art Unit
FRANK W. LU	1634

	SEAR	CHED	
Class	Subclass	Date	Examiner
435	6 91.1 91.2 183 252.3 320.1	6/21/2010	/FL/
436	94 501		
536	23.1 24.3		
	24.33 25.3		

INTERFERENCE SEARCHED				
Examiner				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
STN and EAST (see attached file) Inventor Searches	6/21/2010	/FL/	
Searches SEQ ID Nos: 1 and 2 for identical, homologous and interference searches			